

Search Notes

Application/Control No.

10/693,885

Examiner

B. Clayton McCraw

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
62	176.1, 176.6, 331, 160	2/9/2006	BCM
236	44A, 44C	2/9/2006	BCM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Primary Examiner, Marc Norman	2/9/2006	BCM
Conducted Inventor Name Search	2/9/2006	BCM
EAST Search Notes Attached	2/16/2006	BCM